

**Notice of References Cited**Application/Control No.  
**10/051,003**Applicant(s)/Patent Under Reexam  
**Marks et al.**Examiner  
**Tu M. Nguyen**Art Unit  
**3748**

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**U.S. PATENT DOCUMENTS**

	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Name</b>	<b>Classification</b> <sup>2</sup>	
A	6,422,192	7/2002	Bloomer	123	184.57
B	4,538,556	9/1985	Takeda	123	184.57
C	5,377,629	1/1995	Brackett et al.	181	229
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